	Application/Control No.	Applicant(s)/Patent Under Reexamination
Issue Classification	10787516	VERMAN ET AL.
	Examiner	Art Unit
	Kao, Chih-Cheng G	2882

ORIGINAL	SUBCLASS	INTERNATIONAL	INTERNATIONAL CLASSIFICATION	ATION
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	SUPERVISORY PATENT EXAMINER	EXAMINER	2	20
Musting Moon 4407 (Legal Instruments Examiner) (Date)	(Primary Examiner)	- 8/17/07	O.G. Print Claim(s)	O.G. Print Figure